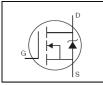


AUTOMOTIVE GRADE

AUIRFR4292 AUIRFU4292

Features

- Advanced Process Technology
- Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *



| V _{DSS} | | 250V |
|---------------------|------|----------|
| R _{DS(on)} | typ. | 275mΩ |
| | max. | 345m $Ω$ |
| I _D | | 9.3A |



| G | D | S |
|------|-------|--------|
| Gate | Drain | Source |

| Description Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, | D S G D-Pak AUIRFR4292 | S G ^D I-Pak AUIRFU4292 |
|--|------------------------------------|--|
| leatures of this design are a 175 C junction operating temperature, | | |

Spe Pov ach fea fast switching speed and improved repetitive avalanche rating . These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

| Base port number Baskage Type | | Standard Pa | ck | Orderable Bort Number | Note | |
|---------------------------------|--------------|---------------------|-----------------|-----------------------|-----------------|--|
| Base part number | Package Type | Form | Quantity | Orderable Part Number | NOLE | |
| AUIRFU4292 | I-Pak | Tube | 75 | AUIRFU4292 | | |
| | | Tube | 75 | AUIRFR4292 | | |
| AUIRFR4292 | 1292 D-Pak | Tape and Reel Left | 3000 | AUIRFR4292TRL | | |
| | | Tape and Reel Right | 3000 | AUIRFR4292TRR | EOL notice #530 | |

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

| Symbol | Parameter | Max. | Units |
|---|---|-------------------------|-------|
| I _D @ T _C = 25°C | Continuous Drain Current, V _{GS} @ 10V | 9.3 | |
| I _D @ T _C = 100°C | Continuous Drain Current, V _{GS} @ 10V | 6.6 | Α |
| I _{DM} | Pulsed Drain Current ① | 40 | |
| $P_D @ T_C = 25^{\circ}C$ | Maximum Power Dissipation | 100 | W |
| | Linear Derating Factor | 0.67 | W/°C |
| V_{GS} | Gate-to-Source Voltage | ± 20 | V |
| E _{AS} | Single Pulse Avalanche Energy (Thermally Limited) ② | 130 | |
| E _{AS} (Tested) | Single Pulse Avalanche Energy Tested Value ® | 97 | mJ |
| I _{AR} | Avalanche Current ① | See Fig.15,16, 12a, 12b | Α |
| E _{AR} | Repetitive Avalanche Energy S | | mJ |
| T _J | Operating Junction and | -55 to + 175 | |
| T_{STG} | Storage Temperature Range | | °C |
| | Soldering Temperature, for 10 seconds (1.6mm from case) | 300 | |

Thermal Resistance

| Symbol | Symbol Parameter | | Max. | Units |
|-----------------|------------------------------------|--|------|-------|
| $R_{\theta JC}$ | Junction-to-Case | | 1.5 | |
| $R_{\theta JA}$ | Junction-to-Ambient (PCB Mount) ∅ | | 50 | °C/W |
| $R_{\theta JA}$ | Junction-to-Ambient | | 110 | |

HEXFET® is a registered trademark of Infineon.

2015-10-12

^{*}Qualification standards can be found at www.infineon.com



Static @ T_J = 25°C (unless otherwise specified)

| | Parameter | Min. | Тур. | Max. | Units | Conditions |
|---------------------------------|--------------------------------------|------|------|------|-------|--|
| $V_{(BR)DSS}$ | Drain-to-Source Breakdown Voltage | 250 | | | V | $V_{GS} = 0V, I_{D} = 250\mu A$ |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient | | 0.31 | | V/°C | Reference to 25°C, I _D = 1mA |
| R _{DS(on)} | Static Drain-to-Source On-Resistance | | 275 | 345 | mΩ | V _{GS} = 10V, I _D = 5.6A ③ |
| $V_{GS(th)}$ | Gate Threshold Voltage | 3.0 | | 5.0 | ٧ | $V_{DS} = V_{GS}$, $I_D = 50\mu A$ |
| gfs | Forward Trans conductance | 6.2 | | | S | $V_{DS} = 50V, I_{D} = 5.6A$ |
| | Drain-to-Source Leakage Current | | | 20 | μA | $V_{DS} = 250 \text{ V}, V_{GS} = 0 \text{V}$ |
| I _{DSS} | Drain-to-Source Leakage Current | | | 250 | μΑ | $V_{DS} = 250V, V_{GS} = 0V, T_{J} = 125^{\circ}C$ |
| | Gate-to-Source Forward Leakage | | | 200 | - Λ | V _{GS} = 20V |
| I _{GSS} | Gate-to-Source Reverse Leakage | | | -200 | nA | $V_{GS} = -20V$ |

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

| = | • | - | - | | |
|------------------|------------------------------|---------|----|----|---|
| Q_g | Total Gate Charge | 13 | 20 | | I _D = 5.6A |
| Q_{gs} | Gate-to-Source Charge | 4.7 | | nC | V _{DS} = 125V |
| Q_{gd} | Gate-to-Drain Charge | 4.8 | | | V _{GS} = 10V3 |
| $t_{d(on)}$ | Turn-On Delay Time | 11 | | | $V_{DD} = 250V$ |
| t _r | Rise Time | 15 | | no | I _D = 5.6A |
| $t_{d(off)}$ | Turn-Off Delay Time | 16 | | ns | $R_G = 15\Omega$ |
| t _f | Fall Time | 8.4 | | | V _{GS} = 10V③ |
| L _D | Internal Drain Inductance | 4.5 | | | Between lead, 6mm (0.25in.) |
| L _S | Internal Source Inductance | 7.5 | | | from package and center of die contact |
| C _{iss} | Input Capacitance | 705 | | | $V_{GS} = 0V$ |
| C_{oss} | Output Capacitance | 71 | | | $V_{DS} = 25V$ |
| C_{rss} | Reverse Transfer Capacitance | 20 | | рF | f = 1.0MHz |
| C_{oss} | Output Capacitance | 600 | | | $V_{GS} = 0V$, $V_{DS} = 1.0V$ $f = 1.0MHz$ |
| C_{oss} | Output Capacitance | 26 | | | $V_{GS} = 0V$, $V_{DS} = 200V$ $f = 1.0MHz$ |
| Coss eff. | Effective Output Capacitance | 65 | | | $V_{GS} = 0V, V_{DS} = 0V \text{ to } 200V $ |

Diode Characteristics

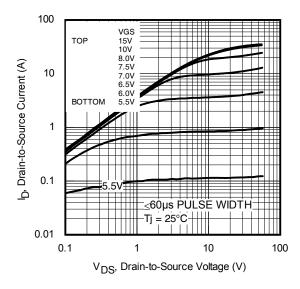
| | Parameter | Min. | Тур. | Max. | Units | Conditions |
|-----------------|--|-----------|--|------|-------|--|
| I _S | Continuous Source Current (Body Diode) | | | 9.3 | _ | MOSFET symbol showing the |
| I _{SM} | Pulsed Source Current (Body Diode) ① | | | 40 | | integral reverse p-n junction diode. |
| V_{SD} | Diode Forward Voltage | | | 1.3 | V | $T_J = 25^{\circ}C, I_S = 5.6A, V_{GS} = 0V$ ③ |
| t _{rr} | Reverse Recovery Time | | 110 | 165 | ns | $T_J = 25^{\circ}C$, $I_F = 5.6A$, $V_{DD} = 125V$ |
| Q_{rr} | Reverse Recovery Charge | | 390 | 585 | nC | di/dt = 100A/µs③ |
| t _{on} | Forward Turn-On Time | Intrinsio | Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D) | | | |

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② Limited by T_{Jmax} , starting $T_J = 25$ °C, L = 8.1mH, $R_G = 50\Omega$, $I_{AS} = 5.6$ A, $V_{GS} = 10$ V. Part not recommended for use above this value.
- \oplus C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}
- © Limited by T_{Jmax}, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- ⑥ This value determined from sample failure population. starting $T_J = 25$ °C, L = 8.1mH, R_G = 50Ω, I_{AS} = 5.6A, V_{GS} =10V.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994

R_θ is measured at T_J approximately 90°C





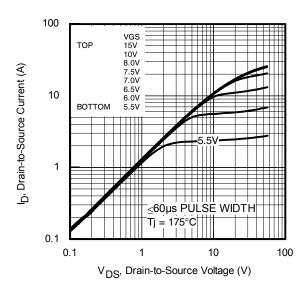
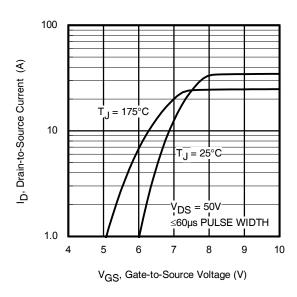
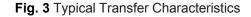


Fig. 1 Typical Output Characteristics

Fig. 2 Typical Output Characteristics





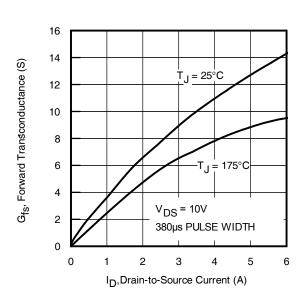


Fig. 4 Typical Forward Transconductance Vs. Drain Current



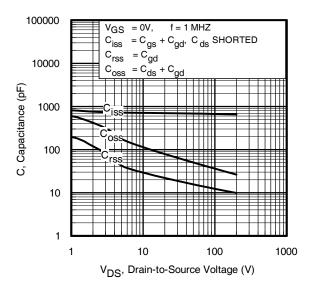


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

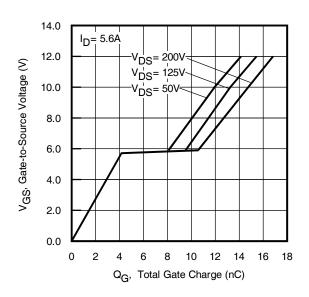


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

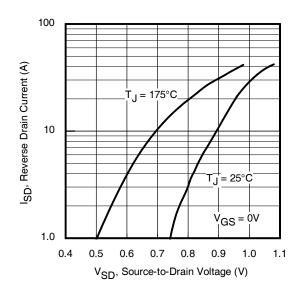


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

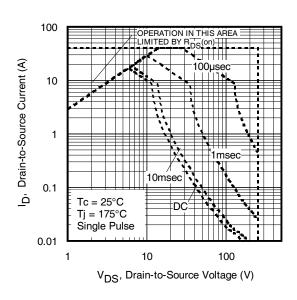
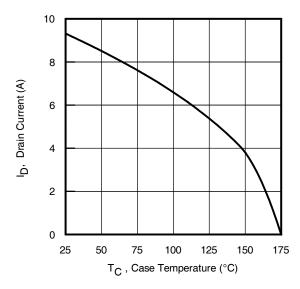


Fig 8. Maximum Safe Operating Area





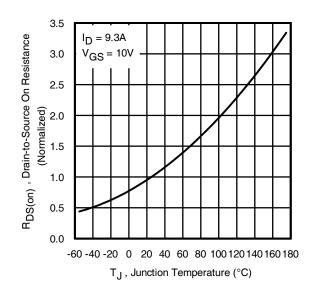


Fig 9. Maximum Drain Current Vs. Case Temperature

Fig 10. Normalized On-Resistance Vs. Temperature

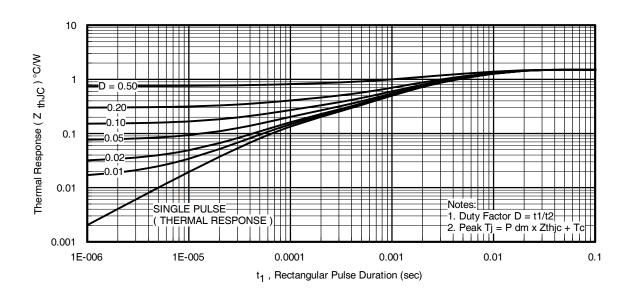


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



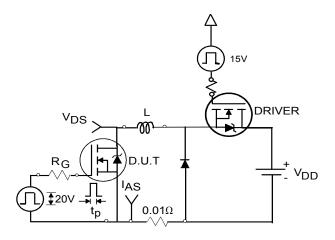


Fig 12a. Unclamped Inductive Test Circuit

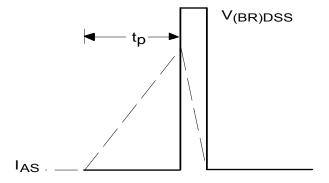


Fig 12b. Unclamped Inductive Waveforms

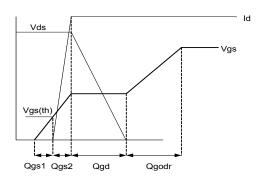


Fig 13a. Gate Charge Waveform

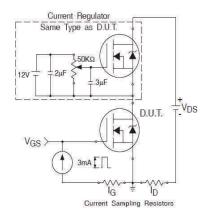


Fig 13b. Gate Charge Test Circuit

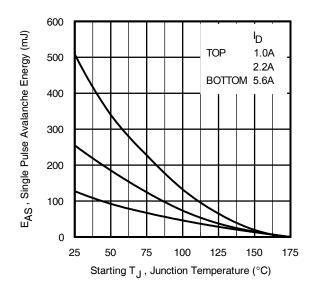


Fig 12c. Maximum Avalanche Energy vs. Drain Current

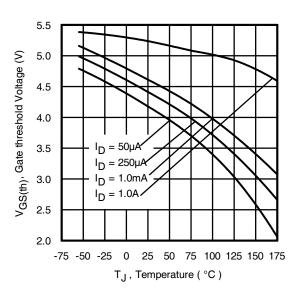


Fig 14. Threshold Voltage Vs. Temperature

2015-10-12



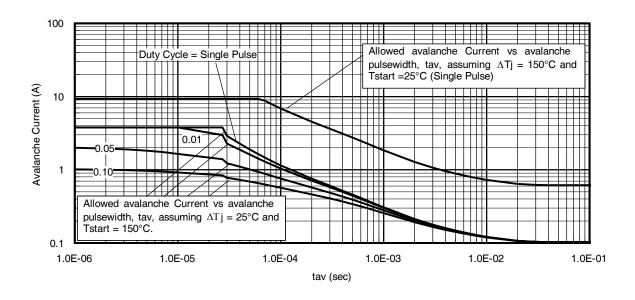


Fig 15. Typical Avalanche Current Vs. Pulse width

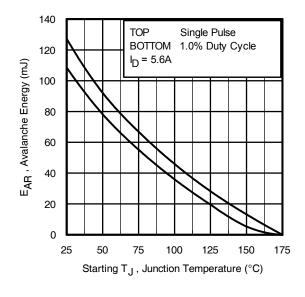


Fig 16. Maximum Avalanche Energy Vs. Temperature

Notes on Repetitive Avalanche Curves, Figures 15, 16:

(For further info, see AN-1005 at www.infineon.com)

- Avalanche failures assumption:
 Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{imax}. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as T_{jmax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 15, 16).

tav = Average time in avalanche.

D = Duty cycle in avalanche = tav ·f

ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{av}) = \Delta T / \; Z_{thJC} \\ I_{av} &= 2\Delta T / \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$

2015-10-12



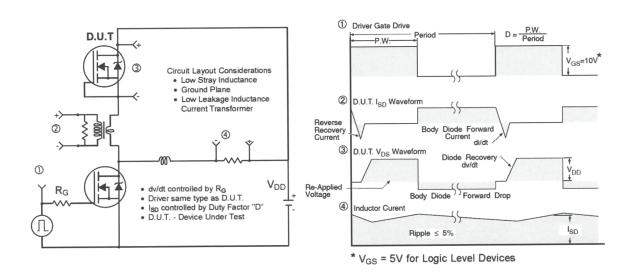


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

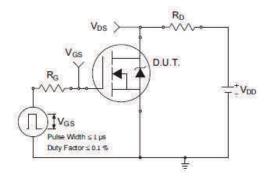


Fig 18a. Switching Time Test Circuit

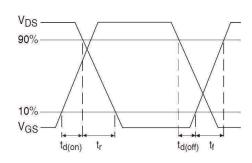
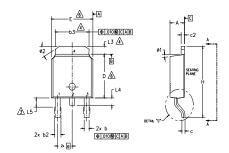


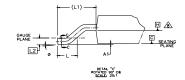
Fig 18b. Switching Time Waveforms

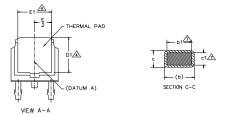


D-Pak (TO-252AA) Package Outline (Dimensions are shown in millimeters (inches))









NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- 1 LEAD DIMENSION UNCONTROLLED IN L5.
- A- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- 5.— SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- ⚠ DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- A- DIMENSION b1 & c1 APPLIED TO BASE METAL ONLY.
- ♠ DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 9.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA.

| S Y M | | DIMEN | SIONS | | Ŋ |
|-------------|--------|-------|-------|------|------------------|
| B | MILLIM | ETERS | INC | HES | O T E S |
| L | MIN. | MAX. | MIN. | MAX. | S |
| Α | 2.18 | 2.39 | .086 | .094 | |
| A1 | - | 0.13 | - | .005 | |
| b | 0.64 | 0.89 | .025 | .035 | |
| ь1 | 0.65 | 0.79 | .025 | .031 | 7 |
| b2 | 0.76 | 1.14 | .030 | .045 | |
| b3 | 4.95 | 5.46 | .195 | .215 | 4 |
| С | 0.46 | 0.61 | .018 | .024 | |
| c1 | 0.41 | 0.56 | .016 | .022 | 7 |
| c2 | 0.46 | 0.89 | .018 | .035 | |
| D | 5.97 | 6.22 | .235 | .245 | 6 |
| D1 | 5.21 | - | .205 | - | 4 |
| Ε | 6.35 | 6.73 | .250 | .265 | 6 |
| E1 | 4.32 | - | .170 | _ | 4 |
| е | 2.29 | BSC | .090 | BSC | |
| Н | 9.40 | 10.41 | .370 | .410 | |
| L | 1.40 | 1.78 | .055 | .070 | |
| L1 | 2.74 | BSC | .108 | REF. | |
| L2 | 0.51 | BSC | .020 | BSC | |
| L3 | 0.89 | 1.27 | .035 | .050 | 4 |
| L4 | - | 1.02 | - | .040 | |
| L5 | 1.14 | 1.52 | .045 | .060 | 3 |
| ø | 0, | 10* | 0, | 10° | |
| ø1 | 0, | 15* | 0, | 15* | |
| ø2 | 25° | 35° | 25* | 35* | |

LEAD ASSIGNMENTS

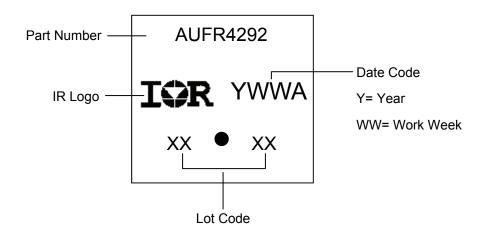
HEXFET

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE
- 4.- DRAIN

IGBT & CoPAK

- 1.- GATE
- 2.- COLLECTOR
- 3.- EMITTER 4.- COLLECTOR

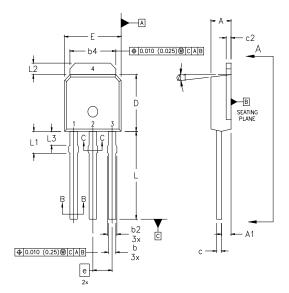
D-Pak (TO-252AA) Part Marking Information

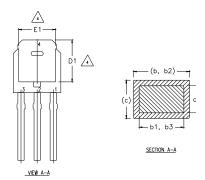


Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



I-Pak (TO-251AA) Package Outline (Dimensions are shown in millimeters (inches)





NOTES:

- 1 DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994.
- 2 DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3 DIMENSION D & E DO NOT INCLUDE MOLD FLASH, MOLD FLASH SHALL NOT EXCEED 0.005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 4 THERMAL PAD CONTOUR OPTION WITHIN DIMENSION 64, L2, E1 & D1.
 - LEAD DIMENSION UNCONTROLLED IN L3.
- 6 DIMENSION 61, 63 APPLY TO BASE METAL ONLY.
 - 7 OUTLINE CONFORMS TO JEDEC OUTLINE TO-251AA.

DIMENSIONS

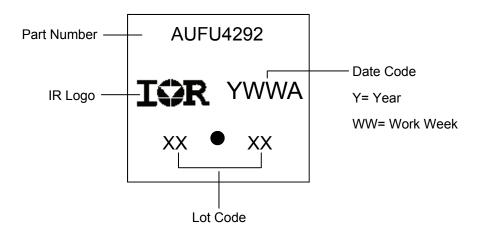
8 CONTROLLING DIMENSION : INCHES.

LEAD ASSIGNMENTS

| ı | н | F | X | F | F | т |
|---|---|---|---|---|---|---|
| | | L | Λ | | L | н |

- 1.- GATE
- 2.- DRAIN 3 - SOURC
- 3.- SOURCE 4.- DRAIN
- SYMBOL MILLIMETERS INCHES MIN. NOTES 2.18 2.39 0.086 .094 A1 0.89 1.14 0.035 0.045 b 0.64 0.89 0.025 0.035 ь1 0.64 0.79 0.025 0.031 b2 0.76 1.14 0.030 0.045 0.76 1.04 0.030 0.041 5.00 5.46 0.195 0.215 b4 0.46 0.61 0.018 0.024 0.016 0.41 0.56 0.022 c1 c2 .046 0.86 0.018 0.035 D 5.97 6.22 0.235 0.245 D1 5.21 0.205 6.35 6.73 0.250 0.265 E1 4.32 0.170 0.090 BSC е L 8.89 9.60 0.350 0.380 L1 1,91 2.29 0.075 0.090 L2 0.89 1.27 0.035 0.050 L3 1.14 1.52 0.045 0.060 15*

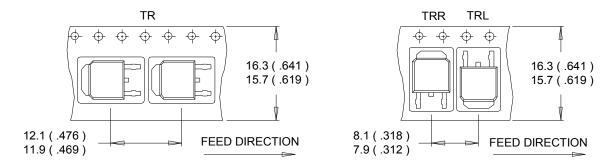
I-Pak (TO-251AA) Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

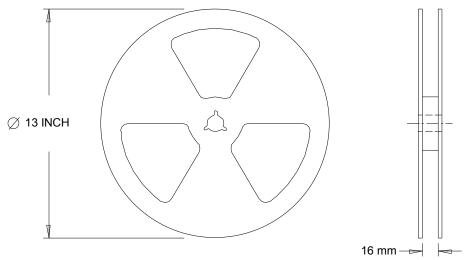


D-Pak (TO-252AA) Tape & Reel Information (Dimensions are shown in millimeters (inches))



NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES:

1. OUTLINE CONFORMS TO EIA-481.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

| | | Automotive (per AEC-Q101) | | | | | |
|----------------|----------------------------|---|-----------------------------------|--|--|--|--|
| | | Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level. | | | | | |
| Maiatuus | Moisture Sensitivity Level | | MCI 4 | | | | |
| Woisture | | | MSL1 | | | | |
| | NA - al-in - NA - al-i | | Class M1B (+/- 100V) [†] | | | | |
| | Machine Model | AEC-Q101-002 | | | | | |
| ECD | Lluman Dady Madal | Class H1A (+/- 500V) [†] | | | | | |
| ESD | Human Body Model | AEC-Q101-001 | | | | | |
| | Charged Davise Medal | | Class C5 (+/- 2000V) [†] | | | | |
| | Charged Device Model | | AEC-Q101-005 | | | | |
| RoHS Compliant | | Yes | | | | | |

† Highest passing voltage.

Revision History

| Date | Comments |
|------------|---|
| 9/2/2014 | Updated datasheet with IR corporate tempalte. |
| | Updated SOA curve Fig 8 from "50V" V _{DS} to "250V" on page 4. |
| | Updated Package outline on page 9 & 10 |
| | Updated ordering information to reflect the End-Of-life (EOL) of the option (EOL notice #530) |
| 10/12/2015 | Updated datasheet with corporate template |
| | Corrected ordering table on page 1. |

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